

<b>Notice of References Cited</b>	Application/Control No. 10/535,526		Applicant(s)/Patent Under Reexamination NAKAMURA ET AL.	
	Examiner LI LIU		Art Unit 2613	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-H0,002,075	08-2003	Gnauck et al.	398/58
*	B	US-2004/0213574	10-2004	Han et al.	398/071
*	C	US-5,907,417	05-1999	Darcie et al.	398/20
*	D	US-2003/0039010	02-2003	Akimoto et al.	359/152
*	E	US-2005/0036785	02-2005	Tervonen et al.	398/049
*	F	US-6,868,232	03-2005	Eijk et al.	398/5
*	G	US-5,539,564	07-1996	Kumozaki et al.	398/2
*	H	US-2003/0142978	07-2003	Lee et al.	398/34
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
*	U	Gerstel et al: "Optical Layer Survivability-An Implementation Perspective", IEEE Journal on Selected Areas in Communications, Vol. 18, No. 10, October 2000, pages 1885-1899.
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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